

Notice of References Cited		Application/Control No. 10/578,930	Applicant(s)/Patent Under Reexamination SUN ET AL.	
		Examiner KIBROM T. HAILU	Art Unit 2461	Page 1 of 1

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B US-2004/0002334	01-2004	Lee et al.	455/436
*	C US-6,577,671	06-2003	Vimpari, Markku	375/146
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FOREIGN PATENT DOCUMENTS

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